

<b>Notice of References Cited</b>	Application/Control No. 10/786,073		Applicant(s)/Patent Under Reexamination HEOR ET AL.	
	Examiner THOMAS D. ALUNKAL		Art Unit 2627	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,314,064	11-2001	Ueda et al.	369/44.23
*	B	US-2003/0103441	06-2003	Kim et al.	369/244
*	C	US-6,304,526	10-2001	Nagashima et al.	369/44.23
*	D	US-6,775,065	08-2004	Hayashi et al.	359/569
*	E	US-2002/0054559	05-2002	Choi, In Ho	369/244
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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